Notice of References Cited Application/Control No. 10/538,884 Examiner Art Unit Page 1 of 1 David E. Bochna Applicant(s)/Patent Under Reexamination AUCHTER ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*	-	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,874,477	04-2005	Lorraine et al.	123/468
*	В	US-6,846,023	01-2005	Ebinger et al.	285/420
*	С	US-6,481,420	11-2002	Panasuk et al.	123/470
*	D	US-6,409,228	06-2002	Fadini et al.	285/305
*	Е	US-6,250,693	06-2001	Gensert et al.	285/364
*	F	US-6,053,149	04-2000	Lorraine, Jack R.	123/470
*	G	US-5,893,351	04-1999	Akutagawa et al.	123/470
*	Н	US-5,820,168	10-1998	De Giacomoni, Jacques	285/192
*	I	US-5,348,353	09-1994	Deweerdt, Kevin R.	285/305
*	J	US-4,461,499	07-1984	Hunter et al.	285/364
*	К	US-3,479,069	11-1969	SEDAM JASON K	285/364
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N			•		
	0					
	Р					
	α					
	R					
_	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	٧						
	w						
	x						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.